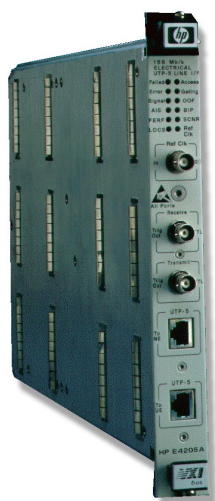


# 155 Mb/s Electrical UTP-5 Line Interface

Agilent Technologies Broadband Series Test System

E4205A



## Product Features

- Cell based implementation
- Operates in both cell and SONET/SDH frame modes
- User-Network Interface (UNI) or Network-Node Interface (NNI) selections
- Provides physical layer measurements as well as error generation
- Internal traffic generator has 1 foreground channel and up to 100 background channels
- Works with Cell Protocol Processor

A line interface for the E4200/E4210 Broadband Series Test System, the E4205A tests the physical interface for ATM cell transmission over Category 5 unshielded twisted-pair wiring.

The Agilent Technologies E4205A 155 Mb/s Electrical UTP-5 Line Interface generates and analyses ATM cell streams contained within a SONET or SDH framing format. It is a single-slot VXI module that provides test capability at the physical and ATM cell layers for the Agilent E4200/E4210 Broadband Series Test System.

The E4205A is capable of operating in both a cell mode and in a SONET/SDH frame mode. This allows the user to not only examine ATM cells mapped into a SONET/SDH frame but also all of the SONET/SDH frame data.

Line interface modules not only connect the device or system under test to your Broadband Series Test System, but also provides physical, convergence, and ATM cell testing capabilities.

Transmission test functionality includes:

- Traffic generation
- Cell error, loss & delay measurements
- Traffic capture & playback



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## Key Features

### Generate Normal or Abnormal Test Traffic

Create and detect erroneous test traffic on demand to test the robustness of a protocol implementation. Sophisticated protocol data unit builder, sequencing, and library functions let you easily create complex and realistic traffic. You can generate test traffic in the foreground channel, and use up to 100 background channels to simulate loading effects.

### Cell Error, Loss & Delay Measurements

Bit error rate testing is done by placing PRBS patterns in cells, and looping these cells back through a system under test.

The received cells are analyzed to detect PRBS errors. These errors can then be used as a trigger to capture data.

Cell delay, interarrival time, and loss measurements are easily accomplished with the BSTS. Timestamps are inserted in cells transmitted by the line interface. These cells can then be captured, and graphs for both cell delay and cell interarrival time displayed.

Sequence numbers are transmitted in ATM cells and looped back through a system under test. The lost cells can then be detected and counted with statistics or used as a trigger to capture data.

You can generate physical and convergence layer errors and alarms. You can also capture and playback convergence layer frames.

Real-time statistics can be gathered for the physical, convergence and cell layers. Statistics can be reported as errored seconds, event counts, or as error ratios.

### Traffic Capture & Playback

Traffic can be captured with a 1500 cell capture memory.

Complete control is available -- continuously capture with memory buffer overlapping, or trigger on user-defined events.

Captured traffic can be played back with automatic decoding into an English-language display. Terminology from standards documents is used wherever possible.

Since high-speed networks carry considerable volumes of traffic, you can increase your test productivity by using filters and triggers to display or capture only traffic of interest.

Filters let you select virtual channels or paths of interest.

Triggers can be used to capture data matching a specific pattern. For example, triggers can be used to capture cells with header errors or sequence number errors, or upon changes in convergence layer frame bytes.

## Typical Applications

The Broadband Series Test System (BSTS) is a modular test platform for high-speed ATM transmission and protocol testing. The BSTS can perform comprehensive testing of all layers, from physical through higher services. Due to its modular nature, you can create a customized configuration that suits your specific test needs. The fully-programmable BSTS is ideal for R&D engineering, product development, quality assurance, performance, type approval, and conformance testing.

The E4205A 155 Mb/s Electrical UTP-5 Line Interface can be used

in conjunction with other BSTS line interfaces, dedicated test modules, and test software to perform these tests.

## Configuration & Use With Other BSTS Line Interfaces, Hardware Modules & Test Software

Line interface modules can perform physical layer testing with a minimal BSTS configuration consisting of a line interface module and chassis.

A complete range of test software applications and dedicated test modules is available to perform upper layer testing.

The E4209 Cell Protocol Processor provides monitoring and simulation test functions at the ATM and adaptation layers by executing optional protocol testing software applications. The CPP performs many functions in hardware that are usually done in software - such as an automatic segmentation and reassembly engine for sophisticated real-time ATM, AAL and other higher layer protocol testing.

The E4219 ATM Network Impairment Emulator module lets you find the limits of performance by inserting impairments into an ATM cell stream. Route in your test cells, set cell delay and loss values to emulate a real-world network, connect the impaired cell stream output to your system under test, and see what happens.

Your local Agilent Technologies field engineer will help you select the best test system configuration to meet your needs. Since the Broadband Series Test System is a flexible and modular ATM/B-ISDN test platform, you can maximize the

return on your test equipment investment by selecting a chassis, line interfaces, dedicated hardware modules, and test software that suits your specific needs. Remember that you can always add extra software or modules at any time.

## Warranty & Support Options

All BSTS hardware components are warranted for a period of 3 years. Products must be returned to an authorized Agilent service center for service. At the time of purchase you may select warranty option W01, a no-charge option which converts the standard 3-year return to Agilent warranty to a 1-year on-site warranty.

Support option UK6, available at time of purchase, is a standards-compliant calibration which ensures that your BSTS test system operates within specified tolerances. A certificate of calibration is issued for compliance with ISO 9000 standards which require that records documenting the calibration of measuring and test equipment are maintained. Certificates of calibration are not available for products which do not contain components requiring calibration (such as software).

Two other types of calibration, commercial and standards-complaint, are available at any time from your local Agilent service center. Both provide test data and a certificate for your records. With a commercial calibration, any problems are resolved as they are detected, and test data reflecting performance of your calibrated test system is provided. The standards-compliant calibration provides comprehensive before and after test data to document problem resolution.

If you should have an out-of-warranty test system, you can arrange for service simply by contacting your local Agilent sales office.

## Product Numbers

- **E4205A** 155 Mb/s Electrical UTP-5 Line Interface
- **E4200A/B** BSTS Form-7 Transportable Chassis
- **E4210A/B** BSTS Form-13 Mainframe Chassis
- **E4209A/B** Cell Protocol Processor
- **E4219A** ATM Network Impairment Emulator

## Technical Specifications

### Traffic Generation

#### Modes

Three Tx/Rx modes are available. In Terminal mode, full signal generation and analysis functions are available. In Repeater mode, the received signal is re-transmitted (physical layer loop back).

In Local Loopback mode, the transmit signal is electrically looped to the receiver.

#### ATM Cell Generation

The transmitted cell stream can contain ATM cells generated internally by the E4205A, and ATM cells generated by an optional E4209 Cell Protocol Processor module. ATM cells generated on-board can consist of one foreground channel to stimulate the channel under test, and up to one hundred background channels for loading purposes. Fill cells are used to occupy unused bandwidth.

Total Bandwidth	<ul style="list-style-type: none"> <li>149.76 Mb/s</li> </ul>
Modes	<ul style="list-style-type: none"> <li>User-Network Interface (UNI) or Network-Node Interface (NNI)</li> </ul>
HEC	<ul style="list-style-type: none"> <li>Automatic generation</li> </ul>
Fill Cells	<ul style="list-style-type: none"> <li>Idle or unassigned</li> </ul>
Channel Priority Order	<ul style="list-style-type: none"> <li>Foreground, background, CPP (highest to lowest priority)</li> </ul>
Channel Control	<ul style="list-style-type: none"> <li>VCI</li> <li>VPI</li> <li>GFC</li> <li>Payload Type</li> <li>Cell Loss Priority</li> </ul>
SAR-PDU Support	<ul style="list-style-type: none"> <li>AAL-0</li> <li>AAL-1</li> </ul>

#### Foreground Channel

Bandwidth	<ul style="list-style-type: none"> <li>From 100 b/s to 149.76 Mb/s with a resolution of +/- 300 b/s</li> </ul>
Accuracy	<ul style="list-style-type: none"> <li>+/- 3 b/s of selected value</li> </ul>
Distribution	<ul style="list-style-type: none"> <li>Off</li> <li>Single burst</li> <li>Periodic (according to the specified bandwidth)</li> </ul>
Channel Depth	<ul style="list-style-type: none"> <li>1500 cells (variable)</li> </ul>
Cell Payload	<ul style="list-style-type: none"> <li>Timestamp</li> <li>Single cell PRBS</li> <li>Cross cell PRBS</li> <li>Data pattern</li> <li>Byte access</li> </ul>

### Background Channels

Number of Channels	<ul style="list-style-type: none"> <li>Up to 100</li> </ul>
Bandwidth	<ul style="list-style-type: none"> <li>3000 b/s to 149.76 Mb/s with a resolution of +/-1.25 kb/s</li> </ul>
Distribution	<ul style="list-style-type: none"> <li>Off</li> <li>Periodic</li> </ul>
Channel Density	<ul style="list-style-type: none"> <li>Bandwidth and cell distribution for each background channel is individually assignable up to maximum bandwidth</li> </ul>
Channel Depth	<ul style="list-style-type: none"> <li>16 cells</li> </ul>
Cell Payload	<ul style="list-style-type: none"> <li>Single cell PRBS</li> <li>Data pattern</li> <li>Byte access</li> </ul>

### Cell Payloads

Payloads	<ul style="list-style-type: none"> <li>Time stamp (32-bit departure time stamp value with 100 nanosecond resolution)</li> <li>Cross cell PRBS-9</li> <li>PRBS-15 (inverted and not inverted)</li> <li>PRBS-23</li> <li>Single cell PRBS-9</li> <li>Data pattern or byte access</li> </ul>
Data Patterns	<ul style="list-style-type: none"> <li>User edit</li> <li>AA55h or FF00h</li> <li>Incrementing (value of each successive byte is incremented by 1)</li> </ul>
Byte Access	<ul style="list-style-type: none"> <li>Payload of all cells in the selected channel can be edited by the user in an active channel environment, or off-line as a sequence of PDUs</li> <li>AAL-1 automatically inserts first payload byte containing SN/SNP values and CSI bit</li> </ul>

## Erroring Control

Error conditions can be introduced to simulate alarm signals and signal stressing. Error stressing is used to generate incorrect bytes in a test signal.

Error Stressing Control	<ul style="list-style-type: none"> <li>Off</li> <li>On</li> <li>Pulse On (error condition is normally off; pulses on)</li> <li>Pulse off (normally on; pulses off)</li> <li>Sequence On (normally off; alternates on/off/on)</li> <li>Sequence Off (normally on; alternates off/on/off)</li> </ul>
ATM Error Injection	<ul style="list-style-type: none"> <li>Cell header or payload bytes with bit error masking</li> </ul>
Cell Loss	<ul style="list-style-type: none"> <li>Sequence Number in the SAR-PDU is skipped and a fill cell is inserted</li> </ul>
PRBS Error Add	<ul style="list-style-type: none"> <li>Single bit error add to the PRBS pattern in the cell payload</li> </ul>

## SONET/SDH Features

SONET/SDH Stressing	<ul style="list-style-type: none"> <li>SPE pointer errors can be introduced once or at a user defined sequence</li> <li>Data errors can be introduced singly or at a rate of 1.0E-9 to 1.0E-3 on to the Section BIP-8, Line BIP-24, Path FEBE and path BIP-8</li> <li>Loss of signal for either a single frame, or continuous</li> </ul>
Framing Formats	<ul style="list-style-type: none"> <li>SONET STS-3c, SDH STM-1</li> </ul>
TOH/SOH	<ul style="list-style-type: none"> <li>Can be any user specified value between 00 and 0ffh (except B1 and B2 bytes)</li> </ul>
B1 and B2	<ul style="list-style-type: none"> <li>Automatically calculated</li> </ul>
D1 to D12	<ul style="list-style-type: none"> <li>User specified</li> </ul>
H1 to H3	<ul style="list-style-type: none"> <li>SPE/AU4 pointer bytes may be set to any fixed value with or without NDF</li> </ul>
Pointer Movement	<ul style="list-style-type: none"> <li>Increment, decrement, or ramping</li> </ul>
SPE/AU4 POH	<ul style="list-style-type: none"> <li>Path overhead can be user specified except for B3 byte which is automatically calculated</li> </ul>
J1	<ul style="list-style-type: none"> <li>User specified 64 or 15 byte path trace message</li> </ul>
G	<ul style="list-style-type: none"> <li>Set Enhanced RDI-P to any of 8 values; REI-P can be user specified</li> </ul>

## ATM, SONET/SDH Measurements

Measurements are sampled every 100 milliseconds and accumulated over the user-specified measurement period. Results from the most recent complete measurement period are retained.

Measurement Period	<ul style="list-style-type: none"> <li>Range 1 second to 3 days in resolutions of 1 second</li> </ul>
Result Types	<ul style="list-style-type: none"> <li>Cumulative or latched (based on most recent measurement period)</li> </ul>
Result Formats	<ul style="list-style-type: none"> <li>Count</li> <li>Ratio</li> <li>Seconds</li> </ul>
ATM Cell Measurements	<ul style="list-style-type: none"> <li>HEC errors</li> <li>Corrected headers</li> <li>Selected cell count</li> <li>Selected cell bandwidth</li> <li>Select Cell Not Received (SCNR) errored seconds</li> </ul>
Cell Delay Measurements	<ul style="list-style-type: none"> <li>Cell delay</li> <li>Inter-arrival time</li> <li>Cell delay variation</li> </ul>
Virtual Channel Errors	<ul style="list-style-type: none"> <li>AAL-1 SN/SNP errors</li> <li>Cell loss</li> <li>PRBS errors</li> <li>PRBS sync loss alarm seconds</li> </ul>
SONET/SDH Measurements	<ul style="list-style-type: none"> <li>Out of frame errors</li> <li>Loss of frame alignment errors</li> <li>Loss of pointer errors</li> <li>Loss of cell synchronization errors</li> <li>Loss of signal errors</li> <li>Line AIS</li> <li>Line FERF</li> <li>Path AIS</li> <li>Path FERF</li> <li>Path yellow</li> <li>Section BIP</li> <li>Line BIP</li> <li>Path BIP</li> <li>Path FEBE</li> <li>Line FEBE</li> <li>Uncorrected HEC errors</li> </ul>

## Traffic Capture & Playback

### ATM Capture

Provides capture of 1500 cells from the selected ATM cell stream. Capture is manual or event triggered. Manual triggering captures 1500 cells after the trigger. Event triggering captures 750 cells pre-trigger, and 750 cells post-trigger.

Manual	<ul style="list-style-type: none"> <li>Triggered on user request</li> </ul>
ATM Cell Triggers	<ul style="list-style-type: none"> <li>Cell loss</li> <li>Header error</li> <li>PRBS error</li> <li>SN/SNP byte error</li> </ul>

### SONET/SDH Capture

When in SONET/SDH frame mode, the E4205 line interface captures and displays TOH data, POH data and path trace messages.

#### Front Panel Connectors and Indicators

To NE	<ul style="list-style-type: none"> <li>To Network-Equipment connector</li> <li>RJ-45 Connector</li> <li>1.0 V into 100 ohms</li> <li>100 ohm balanced impedance</li> </ul>
To UE	<ul style="list-style-type: none"> <li>To User Equipment connector</li> <li>RJ-45 Connector</li> <li>1.0 V into 100 ohms</li> <li>100 ohm balanced impedance</li> </ul>
Reference Clock Input	<ul style="list-style-type: none"> <li>BNC connector</li> <li>10 dbm into 50 ohms</li> <li>155.52 MHz with better than a 60/40% duty cycle</li> </ul>
Rx and Tx Trigger Outputs	<ul style="list-style-type: none"> <li>BNC connectors TTL outputs</li> </ul>
LED Indicators	<ul style="list-style-type: none"> <li>Failed</li> <li>Error</li> <li>Access</li> <li>Ref Clk</li> <li>Gating</li> <li>Signal</li> <li>AIS</li> <li>BIP</li> <li>SCNR</li> <li>FERF</li> <li>LOCS</li> <li>OOF</li> </ul>

## Size, Weight & Power Dissipation

Size	<ul style="list-style-type: none"> <li>1 slot C-size VXI card</li> </ul>
Weight	<ul style="list-style-type: none"> <li>1.3 kg (2.9 lb) nominal</li> </ul>
Power Dissipation	<ul style="list-style-type: none"> <li>37 Watts (max)</li> </ul>

## Applicable Standards

ATM Cells	<ul style="list-style-type: none"> <li>ITU-T Recommendation I.361 1995 B-ISDN ATM layer specification</li> <li>Bellcore TA-NWT-001113 1993 Asynchronous Transfer Mode and ATM Adaptation Layer (AAL) Protocols Generic Requirements</li> </ul>
SONET/SDH	<ul style="list-style-type: none"> <li>SDH as per ITU-T G.708 and I.361 for BSTS software releases prior to A.10; SDH as per ITU-T G.707 (draft) COM 15-163-E, July 1995 Draft revised ITU-T recommendation G.707, Network node interface for the synchronous digital hierarchy (SDH) for BSTS software releases A.10 and later</li> <li>SONET as per Bellcore TA-NWT-000253 for BSTS software releases prior to A.10; SONET as specified by Bellcore GR-253-CORE Synchronous Optical Network (SONET) Transport Systems: Common Generic Criteria for BSTS software releases A.10 and later</li> </ul>
PRBS Patterns	<ul style="list-style-type: none"> <li>PRBS-9 as per ITU-T 0.153 1992</li> <li>PRBS-23 as per ITU-T 0.151 1992</li> </ul>
EMC	<ul style="list-style-type: none"> <li>CISPR11, Class A</li> </ul>

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## Agilent Technologies Broadband Series Test System

The Agilent Technologies BSTS is the industry-standard ATM/BISDN test system for R&D engineering, product development, field trials and QA testing. The latest leading edge, innovative solutions help you lead the fast-packet revolution and reshape tomorrow's networks. It offers a wide range of applications:

- ATM traffic management and signalling
- Packet over SONET/SDH (POS)
- switch/router interworking and performance
- third generation wireless testing
- complete, automated conformance testing

The BSTS is modular to grow with your testing needs. Because we build all BSTS products without shortcuts according to full specifications, you'll catch problems other test equipment may not detect.

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